

Friday 21 November

09:00

TCAD and Surface Damage

Location: CERN, 500/1-001 - Main Auditorium, 503-1-001 (Council Chamber) on 19th Nov; 500-1-001 (Main auditorium) on 20th in the morning and 4-3-006 (TH auditorium) in the afternoon; 500-1-001(Main auditorium) on 21st Nov.

Convener: Gianluigi Casse

09:00-09:20 TCAD simulations of irradiated silicon sensors (Vidyo)

Speaker

Ranjeet Dalal

09:20-09:40

TCAD simulated surface damage in proton irradiated strip sensors: Investigation of interface traps vs non-uniform 3-level model

Speaker

Timo Hannu Tapani Peltola

09:40-10:00 Dopping profile Simulations and measurements

Speaker

Vagelis Gkougkousis

10:00-10:20

Surface Properties of Proton and Gamma Irradiated End-Cap Strip Mini Sensors

Speaker

Marcela Mikestikova

10:20-10:50 Coffee

10:50-11:10

Investigation of the insulator layers for segmented silicon sensors before and after X-ray irradiation

Speaker

Ioannis Kopsalis

11:10-11:30 Alternative technologies for Low Resistance Strip Sensors at CNM

Speaker

Dr Miguel Ullan Comes

11:30-11:50

Electric field and mobility in extremely irradiated silicon

Speaker

Marko Mikuz

11:50-11:55 Mobility in irradiated silicon

Speaker

Prof. Juozas Vaitkus

11:55-12:25 Discussion on TCAD

Speaker
Vladimir Eremin

12:25